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Abstract

Electron microscopy invites the opportunity to locally characterize the properties of solid-state electrolytes important for choreographing ion motion within next-generation solid-state batteries. Through the combination of inert gas transfer, cryogenic, time-resolved low-dose analytical electron microscopy, we observe that mixed-anion sodium *closo*-hydroborate, Na₂(B₁₀H₁₀)_{0.5}(B₁₂H₁₂)_{0.5} (NBH), solid electrolyte suffers from electrostatic charging damage under bias in both transmission electron microscopes and scanning electron microscopes (SEM). During the process of beam damage, crystalline ordering of NBH is lost, while particle morphology remains unchanged. In regions exposed to electron beams at a dose rate of 1–8 e[−] Å^{−2} s^{−1}, spectroscopy confirms a vastly reduced sodium signal or even sodium absence from irradiated NBH at total doses less than 80 e[−] Å^{−2}. Simultaneously, we detect the growth of sodium metal crystals on the unirradiated faces of NBH particles. An SEM experimental study revealed that the maximum damage rate occurs at 2 keV, with increasing energy prolonging the time before sodium is emitted. This work also highlights that cryogenic conditions, while highly effective in mitigating certain types of inelastic beam damage, are not the solution for reducing beam sensitivity. Rather, comprehensive awareness of the underlying physics in competing damage mechanisms is paramount in the selection of operating conditions for battery interface characterization.

Key words: anode free, battery interfaces, cryogenic, damage, electrostatic charging, inert gas transfer, low-dose, sodium *closo*-hydroborate, sodium, solid state electrolytes, solid-state batteries

Introduction

Investigating interfacial mechanisms that govern solid-state batteries on the micro- and nanoscale has the potential to inform future battery design (Zachman et al., 2018; Banerjee et al., 2020; Boebinger et al., 2020; Cheng et al., 2020). Sodium *closo*-hydroborates, a class of sodium solid-state electrolytes (SSE), have demonstrated state-of-the-art thermodynamic stability with sodium metal anodes (Deysher et al., 2022 and Deysher et al., 2024). Significant interest in the sodium all-solid-state battery field has focused on the mixed-anion Na₂(B₁₀H₁₀)_{0.5}(B₁₂H₁₂)_{0.5} composition (NBH), which crystallizes at room temperature in a face-centered cubic phase (typically exhibited by Na₂(B₁₀H₁₀) at high temperature) (Duchêne et al., 2017). This close-packed phase of NBH exhibits a high ionic conductivity of 1.7 mS cm^{−1} and a low electronic conductivity of 1.5 × 10^{−6} mS cm^{−1} at room temperature (Duchêne et al., 2017, 2019; Yoshida et al., 2017). The remarkable stability toward reduction of NBH

and associated lack of an apparent solid electrolyte interphase has enabled desirable anode-free solid-state battery configurations (Deysher et al., 2022; Deysher et al., 2024). A fundamental understanding of sodium ion transport across the interface between NBH and sodium metal has yet to be achieved. As such, the desire for high-resolution imaging and characterization of the bulk structure and solid-solid interfaces of NBH solid electrolytes motivates the careful application of analytical transmission electron microscopy (EM). However, high-resolution imaging of alkali metals and SSE poses serious challenges due to the low melting points and high reactivity (Wang et al., 2017; Zachman et al., 2018; Bai et al., 2026). To this end, the field has adopted cryogenic transfer EM and imaging for studies of these materials (Han et al., 2021; Li et al., 2021). Even with cryogenic EM, this work shows that it is critical to monitor the dose necessary for beam damage when studying sensitive materials.

Modern electron microscopes encompass detectors that capture both the spatial and spectroscopic characteristics of

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specimens. Important techniques include high-resolution imaging (HREM), selected area electron diffraction (SAED), X-ray energy-dispersive spectroscopy (XEDS), and electron energy loss spectroscopy (EELS). However, quantitatively understanding beam damage is necessary to realize the physical limitations of these cutting-edge techniques to study interfaces at a resolution required to gain an understanding of material properties and electrochemical processes. Since the inception of electron microscopy, electron beam damage (and its mitigation) has been critically assessed (Egerton et al., 2004; Baker & Rubinstein, 2010; Jiang, 2015; Zaluzec, 2019), and this will be discussed in the context of the damage mechanism identified for NBH in this paper.

Egerton divided mechanisms of electron beam damage into the primary classes of elastic (electron-nucleus) and inelastic (electron-electron) scattering (Egerton et al., 2004). Within these categories, displacement “knock-on” damage is strongly dependent on the energy of the incident electron beam, and below a threshold energy, the likelihood of displacement can become negligible (Bradley, 1988; Bradley & Zaluzec, 1989; Egerton et al., 2004; Egerton, 2012). This elastic damage mechanism is not mitigated with cryogenic cooling. Inelastic beam damage stems primarily from mechanisms related to radiolysis, heating damage, and deposition of hydrocarbon contaminants. Radiolysis (sometimes referred to as ionization) is anticipated above 1 keV, resulting in a damage rate proportional to the scattering events at each energy of the incident electron beam (Egerton, 2014). Imaging at cryogenic temperatures often offers the most significant benefit for mitigation in these materials by mitigating the thermal diffusion that propagates radiolytic damage (Bai et al., 2026).

In addition to the traditionally evaluated “knock-on” displacement and radiolysis damage mechanisms, an additional damage mechanism that persists in electronically insulating samples stems from electrostatic charging, in which the generation of secondary electrons can result in a surface charge (Cazaux, 1995, 1999, 2006; Lin & Joy, 2005). This is demonstrated by the charge-balanced equation, Equation (1), where electrons from the incident beam (I_0) can either 1) be backscattered, as described by the backscattered coefficient (η); 2) generate secondary electrons (SEs), quantified as the SE yield coefficient (δ); or 3) completely transmit through the sample of interest, measured as the transmitted current (I_t) (Cazaux, 2004). Here, η and δ are dimensionless coefficients relating the quantity of observed backscattered or secondary electrons to those delivered by the incident beam current, respectively. In cases when the sum of transmitted, backscattered, and secondary electrons deviates from the incident current, an excess of charge induces a local sample voltage (V_s) as mediated by the intrinsic electronic resistivity of the insulating sample (R_s) to preserve net charge balance, as the electrical resistance prevents electrons from the regions beyond the electron-beam interaction radius from grounding the sample.

$$I_0(\eta) + I_0(\delta) + I_t - I_0 = \frac{V_s}{R_s} \quad (1)$$

Electrostatic charging damage has been documented in glasses and lithium-based solid electrolytes to cause migration of alkali metal ions and result in their precipitation on the surface as metals (Cazaux, 1993; Jiang et al., 2007; Jiang, 2012; Jiang, 2015; Liang et al., 2020; Peng et al., 2023). Owing to the electron beam having a probability for both elastic and inelastic

interactions with the sample, damage mechanisms often compete and can result in varying predominant damage rates across various imaging conditions (Peng et al., 2023).

Herein, we present a series of time-resolved and correlated electron microscopy experiments to diagnose the beam tolerance of NBH and the mechanism of its destruction. We consider and compare the effects of beam energy, dose rate (d_{rate}), and temperature, as well as present cases for the damage in TEM versus SEM and acceptable electron dosage for future characterization of the NBH system and its interfaces.

Materials and Methods

Materials

Particles of NBH precursors and mixed-anion NBH were dried in a glovebox antechamber under dynamic vacuum at a temperature of 175°C for 72 h and then stored in a sealed container within an argon-atmosphere glovebox (<0.1 ppm H₂O and O₂). The mixed-anion NBH was prepared from precursors following the procedures of Deysher et al. (2022). A 200-mesh copper grid with lacey carbon (no formvar) was dropped into a vial with the powder and cocktail-shaken (with agitation and rotation) for 5 min to disperse particles onto the grid.

Transmission Electron Microscopy

Analytical transmission and scanning transmission electron microscopy (TEM/STEM), XEDS, and EELS measurements in this study were conducted using the Analytical PicoProbe Electron-Optical Beam Line/Iliad Ultra Scanning Transmission Electron Microscope at Argonne National Laboratory (Zaluzec, 2021). The prepared grids were then loaded into the Simple Origin Model 201 inert gas transfer cryogenic TEM holder (Supplementary Fig. S1), whereupon the tip was sealed within the argon gas atmosphere. The holder was then removed from the glovebox via the antechamber and inserted into the TEM column in the room next door after cleaning the external O-ring (< 3 min). The tip of the holder was opened to the airlock antechamber once the pressure gauge was below 1.0×10^{-5} torr in the pumping sequence, and the holder was fully inserted into the column once the pressure gauge was below 3×10^{-6} torr. All operations within the microscope were conducted below 2×10^{-8} torr in the column.

Imaging reported herein was conducted at 60, 80, 200, and 300 keV using high-angle annular dark-field (HAADF) and bright-field STEM using the microscope-integrated Panther detectors. Phase-contrast bright-field conventional TEM images and electron diffraction data were collected on the post-column Ceta II CMOS 4k×4k and Falcon IV cameras. Position-resolved diffraction was collected on an EMPAD 128×128 detector with a 0.7 mrad convergence angle. Observations were conducted at room temperature (23°C) and, as appropriate, under cryogenic (−168°C) modes. XEDS hyperspectral images were collected using the XPAD detector (UltraX prototype) at 300 keV (Zaluzec, 2021). Calibrated doses were achieved by accurate control of beam diameter and beam current. While multiple reproducible experiments were conducted, herein we detail an exemplar TEM + SAED measurement conducted on a mixed-anion NBH particle by a 1 μm diameter probe with 100 pA probe current at 300 keV. A d_{rate} of $\sim 8 \text{ e}^- \text{ \AA}^{-2} \text{ s}^{-1}$ was used

throughout this experiment as measurements iterated between TEM and SAED modes at different locations along the particle. To capture changes dynamically, digital images (frames) were recorded every 500 ms. The diffraction dose study from 60 to 300 keV at room temperature and cryogenic mode employed a d_{rate} of $2 \text{ e}^- \text{ \AA}^{-2} \text{ s}^{-1}$ for NBH and $8 \text{ e}^- \text{ \AA}^{-2} \text{ s}^{-1}$ for sodium to finely resolve their dose threshold to destruction. A d_{rate} of 20 and $50 \text{ e}^- \text{ \AA}^{-2} \text{ s}^{-1}$ was able to be used for LiF and NaF dose experiments for determination of damage onset due to their comparative robustness under the electron beam versus NBH and Na. During STEM imaging and hyperspectral XEDS or EELS measurements, calibrated electron beam currents of 100 pA were employed, while probe sizes and operating modes were varied as appropriate to the spatial resolution and dose required, and dwell times of 0.8 ms/pixel were used. Tomography series data in these experiments were recorded using Thermo Fisher Scientific TOMO-5 software with a dose-symmetric acquisition scheme of 6° increments (i.e., 0° , 6° , -6° , -12° , 12° ... 60°). Each tilt recorded and integrated the net XEDS signal of two 256×256 pixel frames (Comet et al., 2024). Hyperspectral STEM + EELS imaging used a dispersion of 0.072 eV per channel on the EELS Zebra detector.

Through a combination of low-dose, low-magnification TEM imaging and SAED, a freshly grown sodium particle was tilted to a zone axis with the interface positioned for HREM. A prealigned HREM field emission gun register was then loaded to the microscope for observation of the sodium | NBH interface at a d_{rate} of $20 \text{ e}^- \text{ \AA}^{-2} \text{ s}^{-1}$ and a frame recording period of every half second. Drift-correlated frame integration in Velox of five 0.5 s frames was used for HREM images of the sodium crystal interface with an NBH particle.

Throughout, no significant hydrocarbon contamination was observed that would affect image or spectroscopy measurements.

Scanning Electron Microscopy

SEM-focused ion beam (SEM-FIB) studies were conducted on a Thermo Fisher Scientific Aquilos-2 dual-beam from 1 to 20 kV across a range of currents listed in the SI at both room temperature and cryogenically cooled to -171°C . Pellet samples were prepared from the NBH dried powders and uniaxially pressed for 3 min at 100 MPa (Deysheer et al., 2022; Deysheer et al., 2024). Pellets were then extracted and fixed to an SEM stub with double-sided carbon tape and inertly transferred from the glovebox to the microscope using a Thermo Fisher Scientific quick-connect transfer system. An Everhardt-Thornley secondary electron (SE) detector was used for imaging measurements. A consistent field of view of $17 \mu\text{m} \times 12 \mu\text{m}$ was used for experiments at all beam conditions, with a 1536 px by 1024 px frame size at a scan speed of 500 ms per frame. The experimental conditions were first tuned on a control area of the sample where sodium was already grown to ensure that the contrast range would be adequate to prevent substantial saturation in later frames. A low-magnification image would be taken at the start and end of each experiment to observe changes outside the field of view. As with the TEM results, these experiments were also reproduced with identical experimental parameters and conditions to collect SEM + XEDS in a Scios-2 Cryo FIB-SEM. Crystals were grown under the same conditions, and then XEDS spectrum line profiles were collected at 5 keV and 1.6 nA.

CASINO Simulations and Electron Yield Calculations

The Monte Carlo program CASINO 3.3.0.4 (Demers et al., 2011) was used to model numerous processes within this study in order to elucidate the mechanisms which we hypothesize electron beam damage. The CASINO simulation input parameters included the experimental density of the prepared NBH pellet, 1.2 g cm^{-3} . Additionally, the compositional formula Na_4B_{22} was implemented, as CASINO is not capable of calculating SE yield for hydrogen-containing compounds.

For approximation of the yield curve of electrons escaping from the surface of NBH, we first describe functions for the electron penetration depth R and the inelastic mean free path of electrons (λ_{MFP}). R was calculated with the Kanaya–Okayama range formula [Equation (2)] across the range of 1–20 keV incident electron energies (E_0) (Kanaya & Okayama, 1972).

$$R = 0.0276 * \frac{AE_0^{1.35}}{Z^{0.89}\rho} \quad (2)$$

The values applied include an average atomic weight, $A = 7.33 \text{ g/atom}$, the effective atomic mass Z for NBH of 6.407 amu, and the experimental density $\rho = 1.2 \text{ g cm}^{-3}$ of the densified pellet (Deysheer et al., 2022).

The function for λ_{MFP} of electrons with respect to incident energy in NBH was derived from the method in Malis et al. (1988) with Equation (3),

$$\lambda = \frac{106\tau E_0}{E_1 \zeta * \ln\left(\frac{2\beta E_0}{E_1 Z}\right)} \quad (3)$$

where τ is a relativistic correction factor, E_1 is the critical energy for SE generation to occur, ζ is the critical energy barrier for secondary electron generation to occur in the system, and β is the collection angle. There are many other models in the literature by which λ_{MFP} of materials can be approximated (Tanuma et al., 1994). The Malis model was selected for our approximation, as NBH fails to meet the criteria for application of the TPP-2M model for λ_{MFP} due to the following combined properties resulting in an invalid negative coefficient (Zemek et al., 2009). The combination of properties, including density (1.2 g cm^{-3}), band gap [estimated to be 5.78 eV using density-functional theory (DFT) calculations with Heyd–Scuseria–Ernzerhof exchange-correlation functional where the atoms and volume are relaxed within a cubic lattice (Heyd et al., 2003)], and plasmon energy (16 eV by TPP-2M estimation and 20.7 eV experimentally), along with delocalized electrons over the hydroborate cages, are ill suited for the TPP-2M model.

The approximations of R and λ_{MFP} were combined to extract an electron yield curve, $\delta + \eta$, as a function of incident beam energy using Equation (4) for SE yield used by Seiler (1983).

$$\delta + \eta = \frac{B\lambda E_0}{R\zeta} \left(1 - e^{-\frac{R}{\lambda}}\right) \quad (4)$$

B is a constant representing the likelihood of escape for an electron from the surface and is < 1 .

Results and Discussion

Beam Damage in TEM and STEM

To understand the mechanisms of beam damage for this NBH solid-state electrolyte, a series of electron imaging, spectroscopy, and diffraction experiments were conducted on particles

of NBH as synthesized via ball-milling (Deysher et al., 2022). Particulate samples were prepared within an argon gas glove-box and inertly transferred to the TEM (confirmed by Supplementary Fig. S1). To illustrate the mechanisms associated with damage in this system, an exemplar data set (taken from a series of 344 measurements) is presented next. Figure 1 (Supplementary Video 1) follows in detail the evolution of a single particle of NBH during three stages of its transformation. Before beginning the first stage, the NBH particle was carefully imaged in low-dose TEM ($<0.5 \text{ e}^- \text{ \AA}^{-2}$) (Fig. 1a) and demonstrated a lightly faceted morphology with diffraction contrast and blunted edges.

The experimental evolution of the identified NBH particle then commenced at a constant d_{rate} of $8 \text{ e}^- \text{ \AA}^{-2} \text{ s}^{-1}$ at 300 keV room temperature throughout the next three stages, where different regions of the particle were examined in both TEM and SAED with a time resolution of 0.5 s (Supplementary Video 1). During stage 1, time-resolved SAED patterns (Figs. 1b, c) were obtained on the region of the particle labeled 1 in Figure 1a. Additional frames are included in Supplementary Figure S2. These SAED patterns demonstrated the crystalline nature of the NBH particle and quantitatively agreed with bulk X-ray diffraction (XRD) measurements (Fig. 1c), indexed to the previously reported face-centered cubic crystal structure (Duchêne et al., 2017). During further time-resolved data acquisition, the NBH particle quickly amorphized from beam-induced damage. Diffraction reflections at nominally larger scattering vectors (e.g., smaller d-spacing) were observed to decay more rapidly. Beyond $84 \text{ e}^- \text{ \AA}^{-2}$, SAED patterns demonstrated only a broad amorphous ring at 1.7 nm^{-1} (d-spacing of $5.9 \text{ \AA}$).

To investigate the impact of imaging conditions on the rate of beam damage and consistency of the damage mechanism, SAED and imaging studies were repeated with varied incident beam energies of 60, 80, 200, and 300 keV at both ambient and cryogenic temperatures (Supplementary Fig. S5, Table 1). Quantitative results from these studies are shown in Figure 1d, which compares the total dose sustained by NBH particles before amorphization at various imaging conditions. As made necessary by the dose stability of NBH at 60 kV of just $7 \pm 2 \text{ e}^- \text{ \AA}^{-2}$ and sodium at 60 keV of $206 \pm 53 \text{ e}^- \text{ \AA}^{-2}$, all experiments for NBH and sodium were conducted between d_{rate} of 1 and $8 \text{ e}^- \text{ \AA}^{-2} \text{ s}^{-1}$, respectively, to ensure detection of the amorphization dose. LiF and NaF, exhibiting higher beam tolerance, benefit from cryogenic temperature and were studied separately at a d_{rate} of 20 and $50 \text{ e}^- \text{ \AA}^{-2} \text{ s}^{-1}$, respectively, until damage onset. The monoclinic precursors of $\text{Na}_2\text{B}_{10}\text{H}_{10}$ and $\text{Na}_2\text{B}_{12}\text{H}_{12}$ were similarly examined in Supplementary Figure S3 and Table 2 at 300 keV for both room temperature and cryogenic temperature. The same trend holds for the precursors as for the mixed-anion NBH. In all three cases, damage onset begins immediately, which is where we may anticipate observing a distinction based on electrochemical properties (Supplementary Figure S4). $\text{Na}_2\text{B}_{10}\text{H}_{10}$ possesses a slightly larger beam tolerance to complete amorphization, although it remains within the range of the other samples. The mixed-anion NBH amorphized at approximately the same dosage as the earliest component, $\text{Na}_2\text{B}_{12}\text{H}_{12}$, which is expected as the $\text{B}_{12}\text{H}_{12}$ cages are a sub-component of the mixed phase. While the amorphization damage process is identical, we see more distinctive sodium growth occur in the mixed-anion NBH, which we attribute to the higher ionic conductivity.

Increased electron beam energy offers greater stability of NBH under the electron beam (e.g., longer time-to-amorphization), as shown in Figure 1d. Additionally, cryogenic temperatures resulted in only minimal benefits toward preserving the crystallinity of the NBH particles, in contrast to other beam-sensitive battery materials (i.e., Li, Na, and common SEI components such as LiF and NaF). The damage mechanisms for LiF and NaF have already been studied in depth by Bai et al. (2026) and attributed to radiolysis in line with Hobbs' prescribed radiation damage pathway for halides (Hobbs, 1978). Here, radiolysis is signified in Supplementary Figure S5 by mass loss in addition to morphology change with the appearance of signature defect aggregate structures. Beam tolerance of LiF and NaF improves at cryogenic conditions but does not improve with decreased beam energy (Fig. 1d, Supplementary Fig. S6, Table 3).

After stage 1, which focused on the evolution of SAED, in stages 2–3 of this exemplar, time-resolved imaging was used to evaluate the resulting implications of NBH beam damage in TEM over time with a continued d_{rate} of $8 \text{ e}^- \text{ \AA}^{-2} \text{ s}^{-1}$. The large NBH particle had experienced a d_{total} of $220 \text{ e}^- \text{ \AA}^{-2}$ when many small particles ($<10 \text{ nm}$ diameter), not previously present in the low-dose overview image, emerged and coated the surface of the NBH SSE (Fig. 1e). These small particles were rapidly damaged by the electron beam via radiolysis damage, which is markedly different from the damage to the NBH. These particle cores experienced mass loss simultaneously with their loss in crystallinity, leaving behind shells that were then destroyed by the irradiation. By d_{total} of $200 \text{ e}^- \text{ \AA}^{-2}$ in region 2 of the exemplar, only the NBH particle remained (supporting frames shown in Supplementary Fig. S7). Terminating this imaging sequence, the contact point of the NBH particle with the lacey carbon TEM grid (region 3 in Fig. 1a) was investigated. Here in Figure 1f, large crystals emerged from this contact point. Contrasting with the small, uniform coating of crystals in region 2, this contact point region contained only two crystals with comparatively large projected lateral dimensions of 200 and 400 nm.

The noticeable difference between stages 2 and 3 in this exemplar is the presence of the carbon grid. Here, it is hypothesized that, after migrating through NBH in response to a positive local charge, sodium ions that reach the contact point with the carbon TEM grid are reduced to sodium metal at a kinetically favorable rate to grow large crystals due to the relative abundance of available electrons from the carbon grid, which is grounded by the TEM holder. Comparatively, sodium ions reaching the surface of the NBH that extends into vacuum encounter a deficiency of available electrons, resulting in no preferential single nucleation site. The small and large crystals grown in stages 2–3 of the exemplar were also seen to form at every beam energy at room temperature from 60 to 300 keV and were indexed to match d-spacings of sodium body-centered cubic (BCC) (SAED in Supplementary Fig. S8–9 and position-resolved diffraction in Supplementary Fig. S10). The sodium diffraction spots are not seen in stage 1 of NBH damage, as the sodium crystals, small and large, nucleate outside of the illuminated area of the beam, with the caveat that large crystals have been seen to grow into the illuminated area from an external nucleation side depending on their growth direction. A dose study of the small crystal sodium and discussion is in the Supplementary supporting information (Supplementary Fig. S11–12, Table 4).

In summation, these reproducible observations suggest that NBH solid electrolyte undergoes a damage mechanism due to

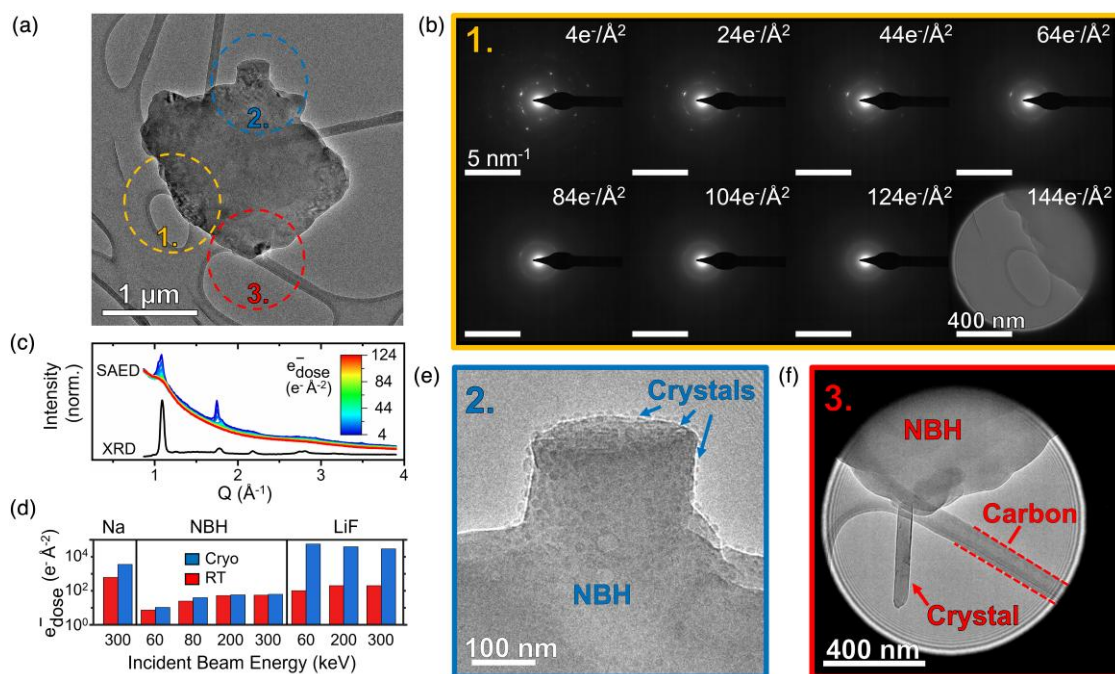


Fig. 1. Low-electron-dose-resolved TEM and SAED experiment for NBH irradiation damage. **(a)** Low-dose TEM image of crystalline $\text{Na}_2(\text{B}_{10}\text{H}_{10})_{0.5}(\text{B}_{12}\text{H}_{12})_{0.5}$ particle. Three regions of sequentially staged experiments conducted on the same particle and described herein are circled. All three stages **(a,b,c,e,f)** were conducted at 300 keV, room temperature, 100 pA, and $1\ \mu\text{m}$ probe diameter for a d_{rate} of $8\ \text{e}^{-}\text{\AA}^{-2}\text{s}^{-1}$. **(b)** Diffraction experiment sequence conducted as stage 1 (yellow circle). **(c)** Radial integrated diffraction profile from the SAED experiment **(c)** compared with capillary XRD acquired with Mo K alpha radiation. **(d)** SAED electron dose stability comparison of sodium metal, NBH, and LiF at room temperature and cryogenic liquid nitrogen temperature across a range of energies. **(e)** Stage 2 (blue circle) small crystal nuclei on opposing sides of the NBH particle from the diffraction experiment site. **(f)** Stage 3 (red circle) large crystal nucleation at the contact point between NBH and lacey carbon TEM grid.

Table 1. TEM Amorphization Dose for Mixed-Anion NBH Across Temperature and Beam Energies.

Beam Conditions	Amorphization Dose ($\text{e}^{-}/\text{\AA}^2$)	Std. Dev ($\text{e}^{-}/\text{\AA}^2$)
300 keV RT NBH	54	7
300 keV Cryo NBH	61	5
200 keV RT NBH	51	6
200 keV Cryo NBH	56	10
80 keV RT NBH	24	6
80 keV Cryo NBH	38	5
60 keV RT NBH	7	2
60 keV Cryo NBH	10	4

electron irradiation that 1) amorphizes the bulk NBH solid electrolyte particle without morphological damage and 2) results in the growth of crystalline particles on the surface of the NBH that evidence suggests are nominally sodium metal. Such sodium metal expulsion occurring in the periphery of the transmission electron beam is consistent with the description of electrostatic beam damage by Jiang (2016).

In addition to the structural details provided from SAED and TEM imaging, spectroscopic techniques (e.g., XEDS and EELS) were employed to obtain elemental insights on the *in situ* grown particles and further inform the mechanism of beam damage. Low-dose STEM XEDS hyperspectral imaging was captured of a pristine NBH particle (Supplementary Fig. S13), considering the dose tolerance limits from Figure 1d, and confirmed the initial homogeneous distribution of sodium and boron throughout. In a complementary experiment, TEM imaging was confined to the region labeled “1” in Figure 2a,

Table 2. TEM Amorphization Dose for $\text{Na}_2\text{B}_{10}\text{H}_{10}$ and $\text{Na}_2\text{B}_{12}\text{H}_{12}$ Precursors at 300 keV at Room Temperature and Cryogenic Temperature.

Beam Conditions	Amorphization Dose ($\text{e}^{-}/\text{\AA}^2$)	Std. Dev ($\text{e}^{-}/\text{\AA}^2$)
300 keV RT $\text{Na}_2\text{B}_{10}\text{H}_{10}$	61	7
300 keV Cryo $\text{Na}_2\text{B}_{10}\text{H}_{10}$	78	5
300 keV RT $\text{Na}_2\text{B}_{12}\text{H}_{12}$	52	11
300 keV Cryo $\text{Na}_2\text{B}_{12}\text{H}_{12}$	57	5

irradiating only a portion of the NBH particle. We expect this localized exposure to drive Na^+ away from the irradiated region and promote sodium growth on the unexposed faces. Consistent with the exemplar, imaging in this region was accompanied by a loss in diffraction contrast from electron-induced beam damage. Following this TEM imaging (and beam damage), a STEM XEDS hyperspectral image was acquired (Figs. 2a, b). The bright-field image, shown in Figure 2a, and the comparison of the boron and sodium K edge-filtered images in Figure 2b indicate three distinct and representative regions resulting from electron-beam-induced damage. The damaged area, which was exposed to a TEM probe (region 1 labeled in Fig. 2a), is devoid of sodium K signal in the XEDS hyperspectral images. Meanwhile, the boron K signal and particle morphology are retained in this region. In contrast, beyond the radius of irradiation by the TEM electron probe (representative region 2 labeled in Fig. 2a), signals from both the boron and sodium K coexist as expected for the pristine NBH stoichiometry. Additional needle-like structures (labeled region 3 in Fig. 2a) were also identified, where the signal from the boron K was lacking and instead the intensity derived

Table 3. TEM Damage Onset Dose for NaF Across Temperature and Beam Energies.

Beam Conditions	Damage Onset Dose ($\text{e}^-/\text{\AA}^2$)	Std. Dev ($\text{e}^-/\text{\AA}^2$)
60 keV RT NaF	300	122.5
60 keV Cryo NaF	6366.7	500.8
80 keV RT NaF	687.5	149.3
80 keV Cryo NaF	7716.7	472.5
200 keV RT NaF	2800.0	212.1
200 keV Cryo NaF	12,400.0	187.1
300 keV RT NaF	3216.7	246.6
300 keV Cryo NaF	15,550.0	576.6

Table 4. TEM Amorphization Dose for Grown Small Sodium Metal Across Temperature and Beam Energies.

Beam Conditions	Amorphization Dose ($\text{e}^-/\text{\AA}^2$)	Std. Dev ($\text{e}^-/\text{\AA}^2$)
60 keV RT Na	205.7	52.6
60 keV Cryo Na	1648	194.2
80 keV RT Na	266	44.5
80 keV Cryo Na	1728	147.1
200 keV RT Na	478.6	124.1
200 keV Cryo Na	2544	92.3
300 keV RT Na	617.6	174.7
300 keV Cryo Na	3640.0	196.1

from sodium K. Further quantitative confirmation is shown in [Figure 2c](#), which compares the resulting XEDS spectra from these distinct representative regions. In addition to the boron and sodium K-shell signals, small amounts of carbon and copper are detected and can be attributed to system peaks from the TEM grid. Together, these results further confirm the ejection of sodium metal from the bulk to the surface of the NBH solid electrolyte after damage from a focused electron beam.

To further confirm the faceted growths as metallic sodium particles, STEM HAADF imaging ([Fig. 2d](#)) and EELS hyperspectral imaging ([Figs. 2f, g](#)) were employed. Before detailed spectrum imaging, HAADF STEM imaging of an NBH particle initiated the growth of two bright faceted particles ([Fig. 2d](#)). Compared in [Figure 2e](#) are low-loss spectra from the sodium particle (region 1 in [Fig. 2d](#)) and from the bulk NBH particle (region 2 in [Fig. 2d](#)). Here, the spectrum obtained from the faceted particle clearly exhibits characteristic plasmon peaks of sodium metal at 5.67 eV and successive multiple plasmon loss ($\delta E \sim 5.7$ eV) peaks at incrementally increased energy loss, confirming the damage-induced growths as sodium metal in conjunction with SAED from [Supplementary Figure S8](#) (Jiang, 2016; Yang et al., 2021). In comparison, the spectrum from the NBH particle exhibits only a broad peak near 20.7 eV in the low-loss EELS region. As a result, spectrum images were mapped of the first sodium plasmon peak and the low-loss peak from NBH to clearly distinguish the sodium crystals from the solid electrolyte. Over the course of the EELS spectral imaging, the needle-like sodium crystal moved from its original position in the HAADF scan in [Figure 2d](#) to flip in orientation and overlap with the solid electrolyte particle in [Figure 2f](#), although the more cubic crystal neighboring it remains where it originated. The NBH EELS spectrum image in [Figure 2g](#) exhibits inhomogeneous intensity due to thickness effects near the center of the two main particles, where the relative log-ratio thickness of our particle,

t/λ , approaches 5. Thicknesses, t , greater than 1 indicate that the λ_{MFP} of an electron transmitting through the sample is expected to experience significant multiple scattering events (Malis et al., 1988).

The preceding results rely on sodium growth occurring outside the irradiated region, observed in a “hide and seek” fashion: a subregion of the particle is irradiated, inducing sodium growth beyond the active field of view, and the deposits are subsequently located by imaging the surrounding areas (such as in [Figs. 1e–1f](#)). To expand control over our understanding of the sodium expulsion into different sites and sizes, we additionally captured the growth of sodium crystals with another live technique. While traditional TEM and STEM experiments capture 2D projections, the evolution of 3D morphology is logically required to confirm our hypothesis that the large crystals extrude from the contact point with the grid in relation to charging damage. Therefore, STEM + XEDS tomography with $\pm 60^\circ$ tilt was also conducted, the results from which ([Fig. 3](#), [Supplementary Video 3](#)) support our hypothesis from the 2D projections. The tomography experiment detailed in [Figure 3](#) also highlights that, after expulsion of sodium from the bulk NBH initially grows as sodium metal crystals on the surface from beam damage; further electron dose next results in sputtering of sodium metal, which subsequently and progressively coats the neighboring carbon TEM grid.

With the ability to tomographically hyperspectral image these large sodium metal crystals interface with NBH, we additionally can probe the interface for a solid electrolyte interphase and glean an understanding of the dose-dependent evolution. To explore this, sodium metal was grown under low-dose conditions of $8 \text{ \AA}^{-2} \text{ s}^{-1}$ from the opposing side of an NBH particle (with the same procedure as the exemplar). Using HREM mode in TEM, it was also possible to observe a crystal lattice having a periodic spacing of $3.02 \text{ \AA}$, which correlates to the sodium (110) predicted spacing ([Figs. 4a–4c](#)). The NBH appears non-crystalline at this orientation/magnification, with the only periodicity from the sodium crystal in the fast Fourier transform ([Fig. 4c](#)). SAED of the sodium crystal was recorded prior to HREM in [Supplementary Figure S14](#) and informs the growth direction of this sodium crystal along the [100] direction, with the largest exposed surface areas being (110) facets. Calculations of sodium BCC surface energy agree with the observed results of (110) facets in their prediction of $(110) < (100) < (111)$ (Perdew et al., 1990; Vitos et al., 1998; Wang & Wang, 2014). This growth direction was also seen in [Supplementary Figure S10a](#). Further information supporting these large crystals as single-crystal sodium is in [Supplementary Figure S10b–c](#), which creates a virtual detector image from the diffraction disk indexed to sodium and XEDS confirming sodium recorded after the position-resolved diffraction.

The compendium of this data clearly demonstrates a consistent damage mechanism induced by a focused electron beam, wherein 1) the bulk NBH solid electrolyte loses sodium content and crystallinity; 2) faceted, crystalline, metallic sodium particles are grown on the surface of the NBH, with a strong preference toward grounded contacts with the TEM grid; and finally 3) metallic sodium metal growths are further damaged via sputtering, with resulting dispersal across the TEM grid support. The change observed is that the primary physical origin of beam damage in NBH is inelastic from electrostatic charging, as opposed to displacement damage or radiolysis, which would result in significant morphological

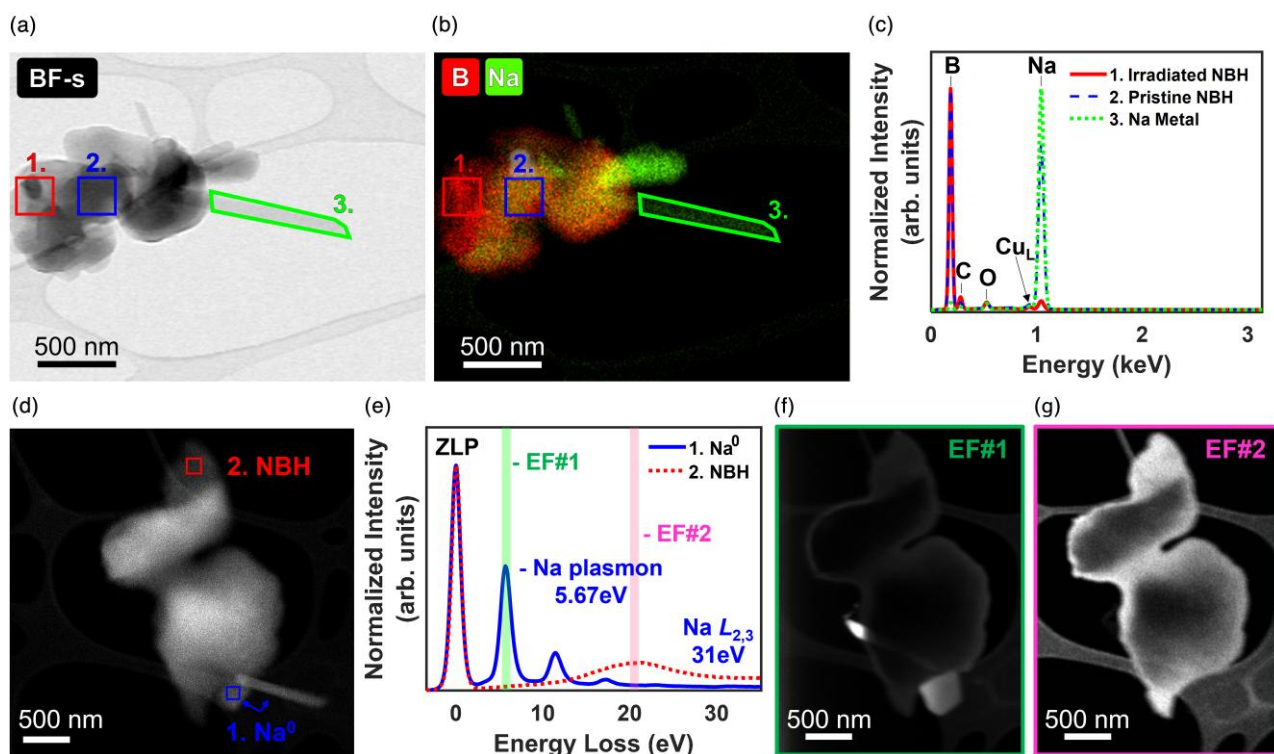


Fig. 2. Spectroscopic studies of NBH electron irradiation damage. (a) Bright-field STEM image of the NBH particle on the lacey carbon TEM grid with green, blue, and red overlays of selected areas integrated into XEDS spectra displayed in (c). Data collected at room temperature, 300 keV, 100 pA, and 1 ms/pixel. The left area was exposed to the electron beam for TEM study and recorded reduced sodium K-shell signal intensity. The center region of the particle is comprised of bulk NBH. The right side features sodium crystals grown from the contact point of the NBH particle and the carbon TEM grid. (b) Boron and sodium XEDS hyperspectral image (HSI) of the NBH particle and sodium crystal growths. HSI is comprised of the net signal of six integrated frames. (c) Extracted spectra from the selected areas in (a). (d) HAADF STEM micrograph pre-EELS hyperspectral image acquisition with two sodium crystals grown. (e) Two low-loss energy spectra from the hyperspectral image integrating 1000 frames: blue, lower corner, metallic plasmon signature matching the literature values for sodium metal, with the primary peak at approximately 5.67 eV. Faint sodium $L_{2,3}$ at 31 eV. Red, no metallic plasmon signature, with an initial low-loss peak near 20.7 eV. Energy-filtered (EF) images for the (f) sodium plasmon and (g) NBH low-loss peak were extracted from the spectrum image and clearly segment the sodium crystal from the SSE particle.

changes. Further, the lack of effectiveness of cryo-protection or reduction of beam energy for increasing NBH beam tolerance is consistent with previous observations of electrostatic charging beam damage of other electronic insulators, including solid electrolytes (Jiang et al., 2007; Peng et al., 2023).

Beam Damage in the SEM

The TEM data, presented herein, were acquired with consistent imaging conditions but are limited in control over geometrical considerations that could influence the damage rate (e.g., incident beam angle and particle thickness) and overall beam tolerance. Therefore, SEM was additionally employed to further investigate the mechanism of electrostatic beam damage with controlled sample thickness and morphology. In contrast to TEM, in SEM, the sample thickness eliminates transmitted electrons from Equation (1), resulting in a limited penetration depth of the incident electron beam into the sample.

The complementary SEM dose study was conducted on the surface of a densified pellet of NBH, which was subjected to a constant rate of irradiation by the electron beam (Supplementary Video 3, Fig. 5a). Initially, and reproducibly, only small pores and impressions from the press are present on the surface of the pristine pellet (Fig. 5a). No visible changes were observed until ~190 s, after which time (and dose) bright features (confirmed to be sodium by XEDS in Supplementary Fig. S15) emerge from the surface at the site of a defect

(Fig. 5b). Further electron irradiation resulted in the growth of sodium metal with a faceted morphology (Fig. 5c) until apparent radiolysis subsequently damaged the sodium metal surface. By 300 s, additional perturbances appeared and grew on the surface and are seen in Figure 5d. These perturbances are the locations where subsequent sodium crystals emerged. The irradiated region was clearly visible with an expanded field of view (Fig. 5e).

A FIB was then subsequently employed to create cross-sectional views through the irradiated region (Fig. 5f, Supplementary Video 4). The FIB rapidly damaged the sodium metal; however, as the cross-sectional slices approached the bulges, pores were revealed beneath the surface. The NBH electrostatic damage affecting crystallinity in this work contrasts with the topotactic reaction seen by Peng et al. for Li growth from the LLZO solid electrolyte, as LLZO retained its crystalline structure during alkali metal expulsion (Peng et al., 2023).

Analogous SEM experiments to Figure 5 were conducted at both cryogenic and room temperature with various beam currents and beam energies in the SEM (results in Figs. 6a–6b and Supplementary Fig. S16–19, Tables 5–6). Comparing first, the effect of beam current on the time required for sodium expulsion at 5 keV (Fig. 6a), lower currents have greater beam tolerance. At 0.4 nA, NBH is stable for almost 607 s at room temperature, while increasing the current exhibits a severe

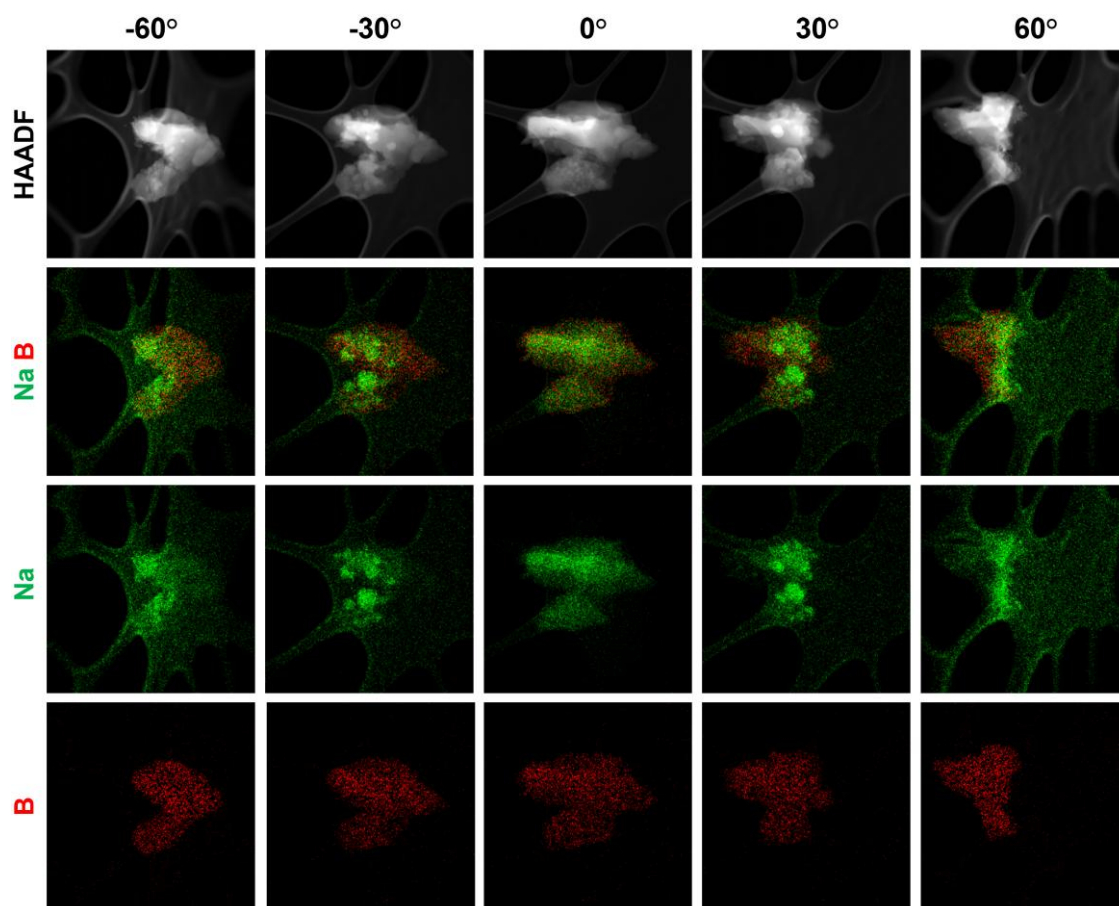


Fig. 3 . STEM + XEDS tomography sequence of NBH particle. Separate views of HAADF signal and integrated net signal spectra for sodium + boron, sodium, and then boron are shown every 30°. The middle column was acquired first in the acquisition scheme.

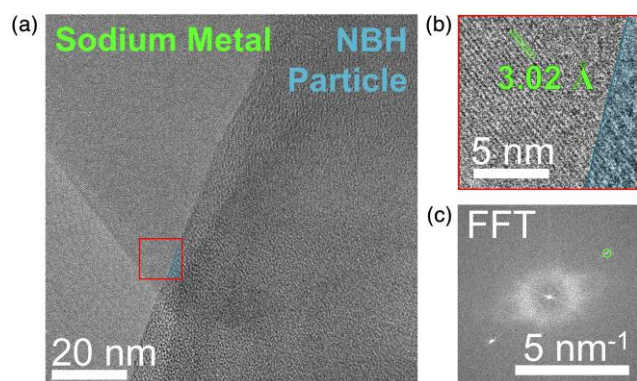


Fig. 4 . HREM of sodium and NBH interface. (a) Drift-correlated frame-integrated image at the NBH particle | sodium metal interface, recorded every 0.5 s at d_{rate} of $20 \text{ e}^- \text{Å}^{-2} \text{s}^{-1}$ for 2.5 s for d_{total} of $100 \text{ e}^- \text{Å}^{-2}$. Pixel size is 49.55 pm. (b) Digitally magnified interface. (c) The FFT of the micrograph.

negative correlation, causing sodium to appear faster and from more nucleation sites. For the largest current employed (26 nA), sodium is expelled from the surface in just 9 s. This trend is in agreement with the expectation that charging and radiolysis scale with electron flux (Egerton, 2014).

Compared with the impact of beam current, the impact of changing beam energy between 1, 2, 5, and 10 keV in

Figure 5b and changing between cryogenic and room temperature was more complex to analyze.

Discussion and Analysis: TEM, STEM, and SEM Beam Damage

To better understand how incident beam voltage and sample temperature influence beam damage, we must understand the possible effects on the probability of SE generation and also the yield from the surface.

Monte Carlo simulations of electron trajectories described previously were employed as a first approximation to determine the interaction volume of the electron beam with the bulk NBH sample across 1–10 keV (Fig. 5c). Given the elemental composition, density (experimentally measured 1.2 g cm^{-3} , plasmon energy 20.7 eV, and simulated work function 6.75 eV) CASINO V3.3.0.4 can estimate the ratio of transmitted, backscattered (BSE, η), and SEs (δ) at a surface (Demers et al., 2011). Following the principles of charge balance and assuming negligible electronic conductivity [Equation (1)], the generation of BSE and SE at proportions greater than the incident beam results in the accumulation of a net positive local charge. However, it should be noted that this version of CASINO is limited in handling the proper generation of secondary electrons produced in hydrogen-containing compounds and in the compensation of delocalized electrons among the borohydride cages.

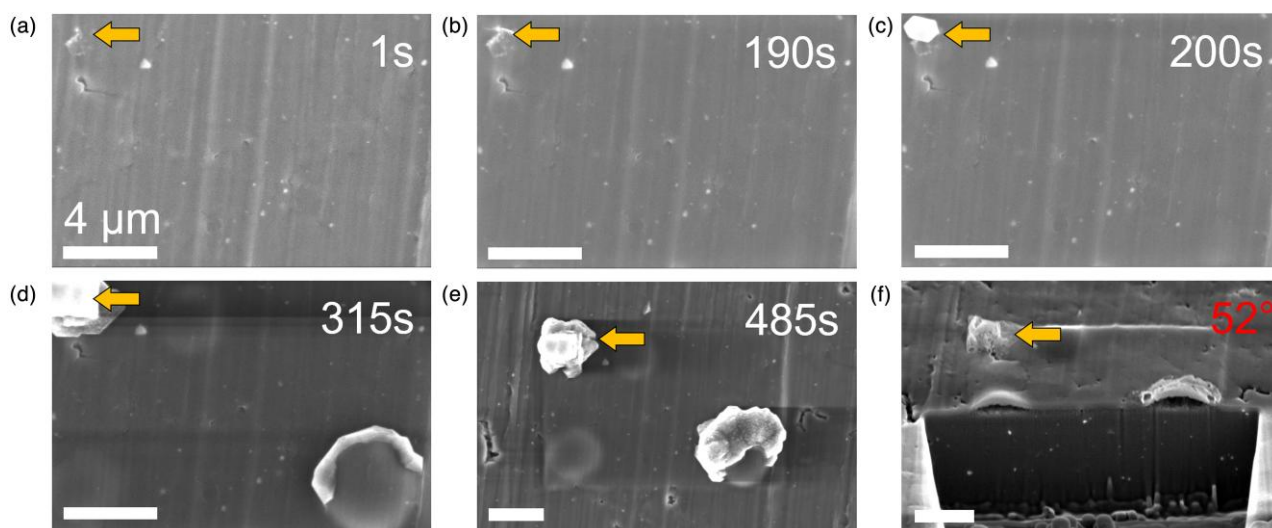


Fig. 5. Inert transfer cryo-SEM damage experiment of a mixed-anion NBH pellet at 5 kV, 1.6 nA, and 500 ns pixel⁻¹ with a field of view of approximately 12 $\mu\text{m} \times 17 \mu\text{m}$ (see [Supplementary Supplementary Video 3](#)). (a,b) The sample appeared unchanged for 190 s. (c) At 200 s, a faceted sodium crystal extruded and grew from the surface. (d) Surface perturbances became apparent and then burst after 300 s. (e) After approximately 500 s, we demagnify to reveal that the electron beam-dosed region has swollen. Several perturbances have grown on the surface. (f) Next, cross sections of the dosed area were revealed with a Ga⁺ ion beam at 30 kV and 2.7 nA (see [Supplementary Supplementary Video 4](#)). All scale bars are 4 μm .

The utility of the CASINO simulations in [Figure 6c](#) is in representing the influence of changing incident beam energy, I_0 , on the interaction volume of the electron beam with NBH, calculated using the Kanaya–Okinawa formula [Equation (2)] ([Kanaya & Okayama, 1972](#)). The resulting R as a function of energy in [Figure 7a](#) matches the CASINO simulated penetration depth in [Figure 6c](#), with values of $R = 30$ and 102 nm, respectively, at 1 and 2 keV. These values already help demonstrate the main consideration of variance between SEM and TEM experiments. The thickness of our SEM sample ($\geq 800 \mu\text{m}$) is vastly greater than the penetration depth, R , of the SEM incident electron beam, whereas our particles in TEM can expect transmission of a majority of the electron current. Next in the pathway to establishing a yield curve, we approximated the probability of generated secondary electrons reaching the NBH surface in order to escape, based upon the λ_{MFP} in [Figure 7c](#). Combining R and λ_{MFP} , we estimate the yield, $\delta + \eta$, in [Figure 7c](#). The yield curve has three regimes representing charging cases. Initially, below 1 keV, $\delta + \eta < 1$, which would result in negative charging of the particle. Between 1 and 13 keV, $\delta + \eta > 1$ predicts positive charging of the interaction volume from excess SE generation. Beyond 13 keV, $\delta + \eta$ drops below unity again. It should be noted that these yield curves do not account for the buildup of charge gradients with time in insulators and are instead an instantaneous evaluation, leaving the possibility of delayed positive charging.

Combining results from the experimental study and the approximated yield curve for the three cases, one can summarize schematics for interactions of the electron beam I_0 with NBH in the SEM (Figs. 7d–7f) and TEM (Fig. 7g). As depicted in [Figures 6d](#) to [6f](#), the beam energy dictates the volume from which backscattered electrons (η) are generated and secondary electrons (δ) knocked out can escape from the surface. The energy distribution left behind by the excess SE will result in positive charging of the irradiated region, which, due to the sluggish electron conduction and lack of charge dissipation, results in the expulsion of the positively charged sodium ions from the structure.

In contrasting the results of the calculated values, one can understand the impact of beam energy on the sodium expulsion in the SEM by comparing the three charging scenarios for NBH. First, at low E_0 ([Fig. 7d](#)), the penetration depth is very small, and the small SE yield from this interaction volume is insufficient to create a large charge gradient in NBH. At intermediate E_0 in [Figure 7e](#), the penetration depth approaches the maximum secondary electron escape depth, L . L is approximated to be close to λ_{MFP} at the maximum yield energy, E_m , in [Figure 7c](#), yielding a value of 126.2 nm ([Cazaux, 2006](#)).

Incident energies at the peak E_m of 3.6 keV will result in the maximum charging scenario by inducing the largest possible interaction volume that can contribute to local positive charging through SE yield. Beyond this E_0 ([Fig. 6f](#)), additional energy results in SE generation deep in the bulk. Such SEs exhibit a low probability of escape. Thus, as incident energy increases further, the majority of SEs are now generated too deep inside the bulk material to contribute to surface charging. This is why, in the experiments illustrated in [Figure 5b](#), above 2 keV, a significantly increased cumulative electron dose was required for sodium expulsion to occur.

At a given current, electron beams with increased energy also exhibit a larger mean free path for electrons transmitted through the sample, thereby lowering the instances of inelastic collisions to generate secondary electrons for two different energy beams at the same current.

The value of E_m for insulators in the literature is commonly around 2 keV but can vary in experimental data due to the influence of sample processing and geometry ([Cazaux, 2006](#)). The calculated E_m of 3.6 keV in [Figure 6c](#) is plausibly ranged in comparison to the trends of our experimental data in [Figure 5b](#), which revealed the most rapid sodium expulsion from NBH at 2 keV. Variance in experimental data from theory derives from the limited treatment of delocalized electrons and hydrogen-terminated hydroborate cages by central assumptions of [Equations \(2\)–\(4\)](#). The hydrogen-terminated hydroborate cages, with two delocalized electrons, are expected

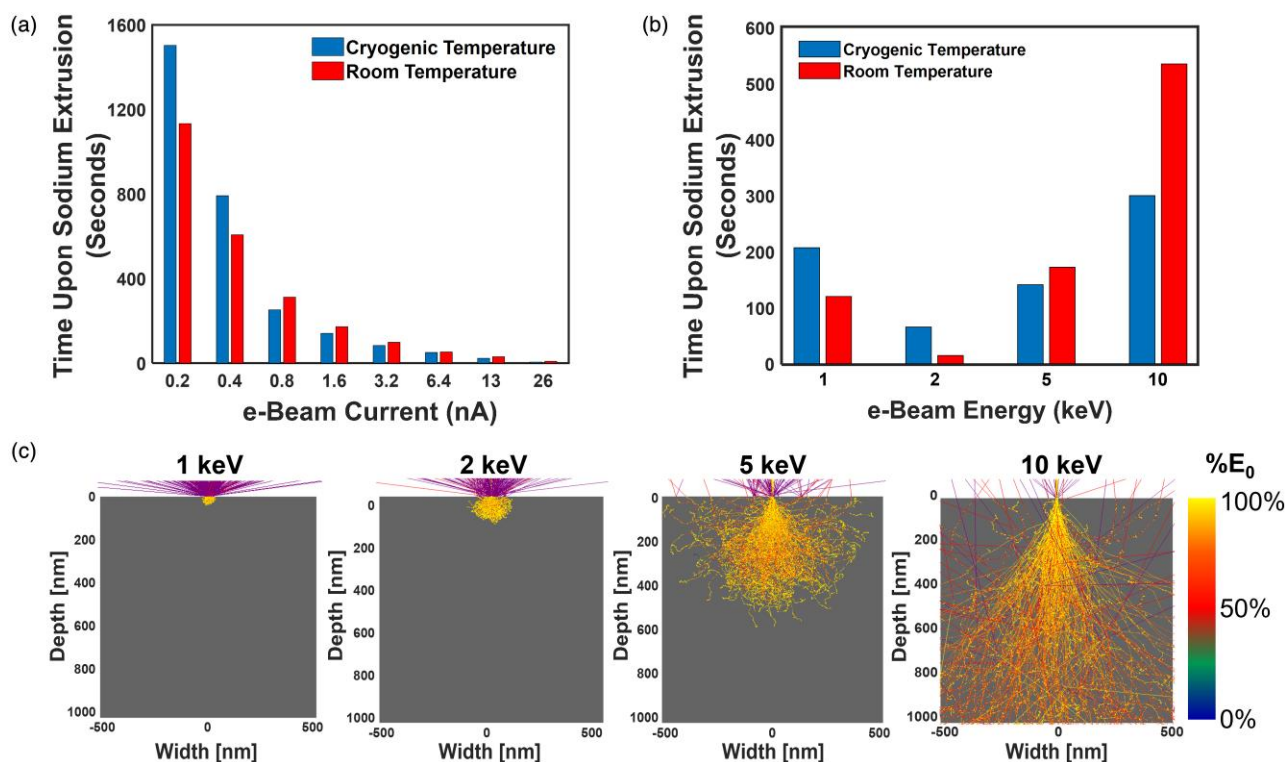


Fig. 6. Time until damage matrix for SEM dose experiments and simulated yield from Monte Carlo mirrors of the evaluated SEM beam energies. **(a)** SEM dose experiment matrix comparing the time until sodium extrudes from the surface of the NBH at varied beam currents and temperatures. **(b)** Similar SEM dose experiment matrix evaluating the effect of e-beam energy and temperature. **(c)** Displays electron dispersion for 1, 2, 5, and 10 keV CASINO Monte Carlo simulations of a $5 \mu\text{m}^3$ volume (magnified to $1 \mu\text{m}^3$) of NBH.

Table 5. SEM Constant Beam Energy, Current Versus Time Until Sodium Expulsion.

Change Current	Cryogenic Temperature (s)	Room Temperature (s)
5 keV 0.2 nA	1503	1133
5 keV 0.4 nA	792	607
5 keV 0.8 nA	252	312
5 keV 1.6 nA	141	172.3
5 keV 3.2 nA	88.3	99
5 keV 6.4 nA	50.5	53
5 keV 13 nA	23	30.3
5 keV 26 nA	5	8.7

to exhibit charging behavior under electron beam bias due to the long mean free path and large band gap energy. Another important distinction between simulation and experiment is the assumption of steady-state flow in contrast to the transient nature of charging during real experiments. Electronic conductors are able to alleviate the impeded positive surface charge with electrons from the bulk, but electronic insulators are susceptible to enhanced charging by dose rate and not solely total dose of electrons.

Above 2 keV, the conventional wisdom of lowering temperature to reduce damage does not apply, as the expanded L enables faster charging of the sample. Knowledge of L is additionally useful in explaining the changing trend in the effect of temperature on the rate of sodium expulsion in the SEM dose experiments. The findings of Cazaux have previously related the increase in electrostatic beam damage at low temperatures to the decrease in electron-phonon interactions (Cazaux, 1993). This decrease would in turn result in an

Table 6. SEM Constant Current, Beam Energy Versus Time Until Sodium Expulsion.

Change Energy	Cryogenic Temperature (s)	Room Temperature (s)
1 keV 1.6 nA	204	120
2 keV 1.6 nA	65.5	14.7
5 keV 1.6 nA	127	172.3
10 keV 1.6 nA	300	535

increase in the escape depth of electrons, which expands the maximum possible volume of NBH contributing to charging, raising E_m . The data trend for temperature in Figure 6b experiences the inversion at the same beam energy range trend inversion of 2–5 keV explained above. Consistency with the predictions in the damage beam tolerance trend across conditions of beam energy and temperature in Figure 6b for SEM and Figure 1d for TEM signifies electrostatic charging as the predominant damage mechanism for NBH.

In contrast to the SEM case, the TEM schematic of Figure 7g emphasizes that most of the electrons are transmitted through the solid electrolyte. As such, a cylindrical charging region in line with the radius of the electron beam will be formed. Collisions with the electron beam have ample energy to displace secondary electrons. As this core can immediately develop a local positive charge, sodium ions will rapidly migrate radially to balance the net charge of the sample. The sodium ions progressing to the surface of the NBH encounter two possible end results. First, sodium ions reaching the particle surface adjacent to the vacuum of the TEM column are seen to nucleate into a large number of small sodium crystals

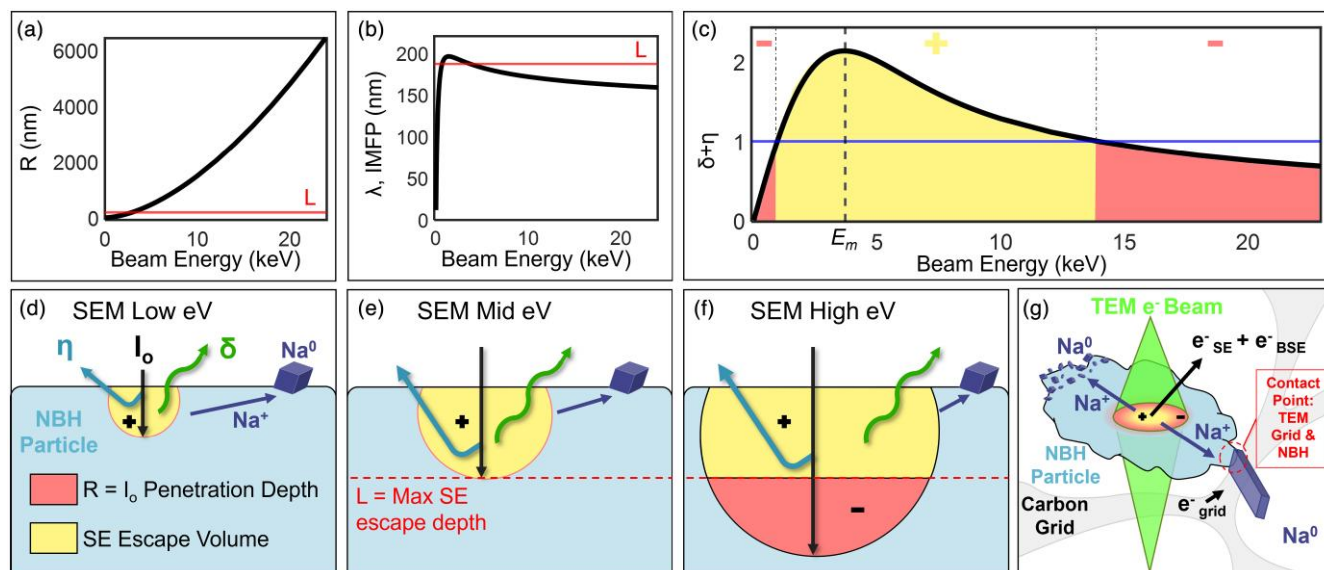


Fig. 7. Calculations for electron yield curve and the resulting schematic models of electron beam interaction with NBH. (a) R as a function of incident beam energy into NBH. (b) Inelastic mean free path of electrons through NBH as a function of electron beam energy. (c) Approximated standard yield curve for NBH as a function of beam energy. (d) Schematic for low I_0 . (e) Case for $R \approx$ SE escape volume. (f) Case for $R \gg$ SE escape volume. (g) Schematic for TEM electron bias of a thin sample at high keV and the resulting motion of electrons and sodium ions through the sample.

(Fig. 1e), whereas sodium ions directed toward the contact point between the NBH and the carbon TEM grid are met at the interface by a grounded, rapidly replenished source of electrons. This contact results in favorable crystal growth kinetics from fewer nuclei, similar to the result in Figure 1f. In studying the pathways of electrons and ions in the pursuit of maintaining charge neutrality, we have revealed the influence of electron probes on NBH SSE.

The NBH electrostatic damage observed in both SEM and TEM compares well with the electrostatic damage seen by Peng et al. for Li growth from the LLZO solid electrolyte (Peng et al., 2023). In both systems, the shared driver is beam-induced charging; the material response, however, differs. LLZO damage was topotactic and retained its crystalline structure during alkali metal expulsion (Peng et al., 2023), whereas NBH amorphizes. Within the scope of this study, we cannot definitively prove the charge-compensation response of the hydroborate cages, but—as the oxidation argument below develops—these results strongly support our hypothesis and warrant its elucidation in a follow-up study.

Functionally, sodium metal batteries require reduction of the Na^+ cation at the surface of the solid electrolyte, as we observe here. We show evidence in Figure 4 that there is no SEI, supporting the conclusion of Deysher et al. (2024) that the interface is stable and well suited to sodium metal batteries. The hydroborate anion sublattice is stable against reduction, which enables the fast-ion structure to remain intact at the anode interface in a solid-state battery (SSB) despite active sodium transport.

The reduction stability above describes the electrochemical response at the interface; the amorphization we observe under the beam belongs to a separate regime. We propose that the electron beam creates locally high-voltage conditions via the ejection of secondary electrons, creating conditions capable of hydroborate anion oxidation, not reduction. Under a locally induced voltage above the NBH oxidation potential of 3.2 V versus Na/Na^+ (Deysher et al., 2024), the hydroborate $\text{B}_{10}\text{H}_{10}^{2-}$

and $\text{B}_{12}\text{H}_{12}^{2-}$ cages would oxidize (Paetzold et al., 2007; Jin et al., 2024). We would anticipate a more complex reaction for the mixed-anion hydroborate cages. Advanced time-resolved EELS capable of detecting changes in the boron binding environment may elucidate this hypothesis, but the rapid structural changes recorded in SAED suggest that capturing this evolution could pose a serious technical challenge. Interpretation would additionally require advanced simulation to distinguish the spectral features representing such a bonding change within a limited electron dose and short time resolution.

These findings contextualize three important takeaways for the SSB field. First, the underlying charging mechanism likely generalizes across lithium and sodium solid-state electrolyte systems, as suggested by both this work and Peng et al.'s study of LLZO (Peng et al., 2023); it should therefore be anticipated broadly, even though the resulting damage morphology can be system-specific—topotactic in LLZO and amorphization in NBH. Second, NBH here demonstrates desirable behavior at the sodium metal interface with the absence of an interphase. Systems that do form interphases may be harder to monitor for charging damage, since byproducts created as the alkali metal is driven to the surface could obscure or complicate assessment. A full suite of characterization techniques should therefore be used to track spatial, chemical, and morphological changes during irradiation on individual systems before characterizing composite, interface-containing systems. Third, charging damage is not resolved by cryogenic temperatures (Fig. 1d, Figs. 6a–6b). Future mitigation could include conductive coatings, but these must be applied carefully to avoid altering the composition or conduction pathways of the native interfaces of interest, a consideration that extends beyond TEM and SEM measurement to FIB-SEM lamella preparation as well.

Conclusions

Sodium *closo*-hydroborates represent an important class of sodium solid-state electrolytes owing to their appreciable ionic

conductivity, favorable mechanical properties, and thermodynamic compatibility with sodium metal anodes that together enable anode-free configurations with efficient ion transfer. However, compared with other beam-sensitive battery materials such as sodium metal, studying these solid electrolytes with electron microscopes presents additional challenges outside of the dominant and well-known radiolytic damage mechanisms. While cryogenic EM aids the beam stability of alkali metals, NBH exhibits a primary damage mechanism of electrostatic charging due to excess secondary electron generation and low electronic conductivity that is not significantly mitigated by cryo-protection. Here, we show that NBH exhibits an onset of beam damage even before a dose of $10 \text{ e}^- \text{ \AA}^{-2}$, which results in complete amorphization before $80 \text{ e}^- \text{ \AA}^{-2}$ at 300 keV. In response to positive charging by the electron beam, sodium metal was extruded from the bulk particle, either as small nuclei that coat the particle surface or as large, faceted crystals at grounded contact points between the NBH particle and the lacey carbon TEM grid. The interface between NBH and sodium displayed no significant chemical gradients in boron content nor featured an amorphous interlayer of distinct contrast supporting the conclusion that there is no SEI formation. A systematic search of beam energies found that an experimental maximum charging rate occurs at 2 keV, with decreasing damage rates at higher energies. In conjunction with experimentation, Monte Carlo simulations and calculations support positive charging induced by secondary electron generation of NBH. Increasing voltage does not eliminate the damage mechanism, but by increasing the interaction volume proportionally to the inverse electron wavelength, it decreases the charge per area, prolonging stability with the increased resolution. From these studies, we strongly advocate and recommend that all EM studies of solid electrolytes undergo careful dose evaluation prior to making mechanistic conclusions about battery performance. Just as high-speed detectors with large signal-to-noise enabled these studies, the authors remain optimistic that single-frame 4D-STEM offers an avenue for future imaging of beam-sensitive solid-state electrolytes, such as sodium hydroborates.

Availability of Data and Materials

The data that support the findings of this study are available at <https://data.energystoragera.org/data> or from the corresponding author upon reasonable request.

Supplementary Material

To view [supplementary material](#) for this article, please visit <https://doi.org/10.1093/mam/ozag104>.

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Conflict of Interest

The authors declare that they have no competing interest.

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